

FE	ATURES		
•	Member of the Texas Instruments Widebus™ Family	DGG, DGV, OR (TOP \	/IEW)
•	Operates From 1.65 V to 3.6 V	1 <u>0</u> E [] 1	⁴⁸ 1CLK
•	Inputs Accept Voltages to 5.5 V	1Q1 2	47] 1D1
•	Max t _{pd} of 4.5 ns at 3.3 V	1Q2 3	46 1D2
•	Typical V _{OLP} (Output Ground Bounce) <0.8 V at V _{CC} = 3.3 V, T _A = 25°C	GND [] 4 1Q3 [] ⁵ 1Q4 [] 6	45 GND 44 11D3 43 1D4
•	Typical V _{OHV} (Output V _{OH} Undershoot) >2 V at V _{CC} = 3.3 V, T _A = 25°C	V _{CC} [7 1Q5 [8	42 0 V _{CC} 41 0 1D5
•	I _{off} Supports Partial-Power-Down Mode Operation	1Q6	40] 1D6 39] GND
•	Supports Mixed-Mode Signal Operation on All Ports (5-V Input and Output Voltages With 3.3-V V _{CC})	1Q7 [11 1Q8 [12 2Q1 [13	38 1D7 37 1D8 36 2D1
•	Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors	2Q2 [14 GND [15	35 2D2 34 GND
•	Latch-Up Performance Exceeds 250 mA Per JESD 17	2Q3 [16 2Q4 [17 Vcc [18	33 2D3 32 2D4 31 V _{CC}
•	ESD Protection Exceeds JESD 22	V _{CC} [18 2Q5 [19	30 2D5
	– 2000-V Human-Body Model (A114-A)	2Q5 [] 20 2Q6 [] 20	29 2D6
	- 1000-V Charged-Device Model (C101)	GND 21	28 GND
		2Q7 🛛 22	27 2D7
DE	SCRIPTION/ORDERING INFORMATION	2Q8 🛛 23	26 0 2D8
	s 16-bit edge-triggered D-type flip-flop is designed 1.65-V to 3.6-V $\rm V_{CC}$ operation.	2 <mark>0E</mark> [24	25 2CLK

ORDERING INFORMATION

T _A	PACKA	(GE ⁽¹⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	FBGA – GRD	- Tape and reel	SN74LVCH16374AGRDR	LDH374A
	FBGA – ZRD (Pb-free)	Tape and Teel	SN74LVCH16374AZRDR	
		Tube	SN74LVCH16374ADL	
	SSOP – DL	Tube	74LVCH16374ADLG4	LVCH16374A
	330P - DL	Topo and real	SN74LVCH16374ADL	
–40°C to 85°C		Tape and reel	74LVCH16374ADLRG4	
-40 C 10 85 C	TSSOP – DGG	Tape and reel	SN74LVCH16374ADGGR	- LVCH16374A
	1330F - DGG	Tape and Teel	74LVCH16374ADGGRG4	LVCH10374A
	TVSOP – DGV	Topo and real	SN74LVCH16374ADGVR	LDH374A
	TVSOP - DGV	Tape and reel	74LVCH16374ADGVRE4	
	VFBGA – GQL	Tapa and real	SN74LVCH16374AGQLR	LDH374A
	VFBGA – ZQL (Pb-free)	 Tape and reel 	SN74LVCH16374AZQLR	

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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DESCRIPTION/ORDERING INFORMATION (CONTINUED)

A buffered output-enable (\overline{OE}) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

OE does not affect internal operations of the flip-flop. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of this device as a translator in a mixed 3.3-V/5-V system environment.

Active bus-hold circuitry holds unused or undriven inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

The SN74LVCH16374A is particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers. It can be used as two 8-bit flip-flops or one 16-bit flip-flop. On the positive transition of the clock (CLK) input, the Q outputs of the flip-flop take on the logic levels set up at the data (D) inputs.

This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

GQL OR ZQL PACKAGE (TOP VIEW)									
	_1	2	3	4	5	6	_		
A	0	()	0	0	0	()			
в	0	()	()	()	О	()			
С	0	()	()	()	()	0			
D	0	()	()	()	(()			
Е	0	()			()	0			
F	0	()			\bigcirc	0			
G	0	()	()	0	()	()			
Н	0	()	()	0	()	О			
J	0	()	()	0	()	0			
κ	0	0	0	0	0	0	J		

TERMINAL ASSIGNMENTS⁽¹⁾ (56-Ball GQL/ZQL Package)

	1	2	3	4	5	6
Α	1 0E	NC	NC	NC	NC	1CLK
в	1Q2	1Q1	GND	GND	1D1	1D2
С	1Q4	1Q3	V _{CC}	V _{CC}	1D3	1D4
D	1Q6	1Q5	GND	GND	1D5	1D6
Е	1Q8	1Q7			1D7	1D8
F	2Q1	2Q2			2D2	2D1
G	2Q3	2Q4	GND	GND	2D4	2D3
н	2Q5	2Q6	V _{CC}	V _{CC}	2D6	2D5
J	2Q7	2Q8	GND	GND	2D8	2D7
Κ	2 <mark>0E</mark>	NC	NC	NC	NC	2CLK

(1) NC - No internal connection

TERMINAL ASSIGNMENTS⁽¹⁾ (54-Ball GRD/ZRD Package)

	1	2	3	4	5	6
Α	1Q1	NC	1 0E	1CLK	NC	1D1
в	1Q3	1Q2	NC	NC	1D2	1D3
С	1Q5	1Q4	V _{CC}	V _{CC}	1D4	1D5
D	1Q7	1Q6	GND	GND	1D6	1D7
Е	2Q1	1Q8	GND	GND	1D8	2D1
F	2Q3	2Q2	GND	GND	2D2	2D3
G	2Q5	2Q4	V _{CC}	V _{CC}	2D4	2D5
н	2Q7	2Q6	NC	NC	2D6	2D7
J	2Q8	NC	2 <mark>0E</mark>	2CLK	NC	2D8

(1) NC - No internal connection

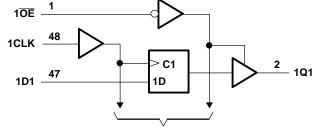
		(TOP VIEW)								
		1	2	3	4	5	6			
Α	ſ	С	С	С	С	С	С			
в		С	С	С	С	С	С			
С		\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	С			
D		С	\bigcirc	\bigcirc	\bigcirc	\bigcirc	С			
Е		\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	С			
F		С	\bigcirc	\bigcirc	\bigcirc	\bigcirc	С			
G		\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	С			
н		С	\bigcirc	\bigcirc	\bigcirc	\bigcirc	С			
J		\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc			
								7		

GRD OR ZRD PACKAGE

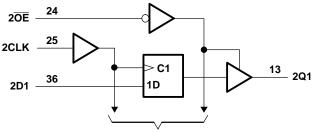
FUNCTION TABLE (EACH FLIP-FLOP)

	INPUTS		OUTPUT
OE	CLK	D	Q
L	\uparrow	Н	Н
L	\uparrow	L	L
L	H or L	Х	Q_0
н	Х	Х	Z

LOGIC DIAGRAM (POSITIVE LOGIC)



To Seven Other Channels



To Seven Other Channels

Pin numbers shown are for the DGG, DGV, and DL packages.

Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT	
V _{CC}	Supply voltage range		-0.5	6.5	V	
VI	Input voltage range ⁽²⁾	but voltage range $^{(2)}$ bltage range applied to any output in the high-impedance or power-off state $^{(2)}$ bltage range applied to any output in the high or low state $^{(2)(3)}$ but clamp current $V_1 < 0$ but clamp current $V_0 < 0$ bott current $V_0 < 0$ bott current DGG package bott charge thermal impedance $^{(4)}$ DGV package GQL/ZQL package GRD/ZRD package				
Vo	Voltage range applied to any output in	age range (2) ange applied to any output in the high-impedance or power-off state (2) ange applied to any output in the high or low state (2)(3) app current $V_1 < 0$ amp current $V_0 < 0$ as output current $V_0 < 0$ as current through each V_{CC} or GND DGG package DGV package DL package				
Vo	Voltage range applied to any output in	the high or low state ⁽²⁾⁽³⁾	-0.5	-0.5 6.5 -0.5 6.5 -0.5 6.5 -0.5 6.5		
I _{IK}	Input clamp current	V ₁ < 0		-50	mA	
I _{OK}	Output clamp current	V _O < 0		-50	mA	
I _O	Continuous output current			±50	mA	
	Continuous current through each V_{CC}	or GND		$\begin{array}{c cccc} 0.5 & 6.5 \\ 0.5 & 6.5 \\ 0.5 & 6.5 \\ 0.5 & V_{CC} + 0.5 \\ \hline & -50 \\ \hline & -50 \\ \hline & \pm 50 \\ \hline & \pm 100 \\ \hline & & 100 \\ \hline & & 58 \\ \hline & & 63 \\ \hline & & 42 \\ \hline & & 36 \\ \hline \end{array}$	mA	
		DGG package		70		
		DGV package		-50 ±50 ±100 70 58		
θ_{JA}	Package thermal impedance ⁽⁴⁾	DL package		63	°C/W	
		GQL/ZQL package		42		
		GRD/ZRD package		$\begin{array}{c} 6.5\\ 6.5\\ \hline \\ V_{CC} + 0.5\\ -50\\ \pm 50\\ \pm 100\\ \hline \\ 58\\ 63\\ \hline \\ 42\\ 36\\ \end{array}$		
T _{stg}	Storage temperature range		-65	150	°C	

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The value of V_{CC} is provided in the recommended operating conditions table.

(4) The package thermal impedance is calculated in accordance with JESD 51-7.

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Recommended Operating Conditions⁽¹⁾

			MIN	MAX	UNIT	
\ <i>\</i>	Quantu unita na	Operating	1.65	3.6	V	
V _{CC}	Supply voltage	Data retention only	1.5		V	
		V _{CC} = 1.65 V to 1.95 V	$0.65 \times V_{CC}$			
VIH	High-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		V	
		V _{CC} = 2.7 V to 3.6 V	2			
		V _{CC} = 1.65 V to 1.95 V		$0.35\times V_{CC}$		
VIL	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7	V	
		V _{CC} = 2.7 V to 3.6 V		0.8		
VI	Input voltage	L	0	5.5	V	
V	Outsut uslike se	High or low state	0	V _{CC}	V	
Vo	Output voltage	High-impedance state	0	5.5	V	
		V _{CC} = 1.65 V		-4		
	I Park lands to devid a constant	V _{CC} = 2.3 V		-8		
I _{OH}	High-level output current	V _{CC} = 2.7 V		-12	mA	
		$V_{CC} = 3 V$		$7 \\ 2 \\ 0.35 \times V_{CC} \\ 0.7 \\ 0.8 \\ 0.5.5 \\ 0 \\ -4 \\ -8 \\ -12 \\ -24 \\ 4 \\ 8 \\ 12 \\ 24 \\ 10 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ $		
		V _{CC} = 1.65 V		4		
	Law boot a day tangent	V _{CC} = 2.3 V		8		
I _{OL}	Low-level output current	V _{CC} = 2.7 V		12	mA	
		$V_{CC} = 3 V$		24		
$\Delta t/\Delta v$	Input transition rise or fall rate	· · · · ·		10	ns/V	
T _A	Operating free-air temperature		-40	85	°C	

(1) All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

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Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDIT	IONS	V _{cc}	MIN	TYP ⁽¹⁾	MAX	UNIT
	I _{OH} = -100 μA		1.65 V to 3.6 V	$V_{CC} - 0.2$			
	$I_{OH} = -4 \text{ mA}$		1.65 V	1.2			
V	$I_{OH} = -8 \text{ mA}$		2.3 V	1.7			V
V _{OH} V _{OL} I _I I _{I(hold)}	1 – 12 mA		2.7 V	2.2			v
	$I_{OH} = -12$ IIIA		3 V	2.4			
	$V_{OH} \begin{array}{c c c c c c c c c c c c c c c c c c c $						
	I _{OL} = 100 μA		1.65 V to 3.6 V			0.2	
	I _{OL} = 4 mA		1.65 V			0.45	
V _{OL}	I _{OL} = 8 mA		2.3 V			0.7	V
V _{OH} V _{OL} I _I I _{I(hold)} I _{off} I _{OZ} I _{CC}	I _{OL} = 12 mA	2.7 V			0.4		
	$I_{OL} = 24 \text{ mA}$		3 V			0.2 0.45 0.7 0.45 0.7 0.45 10 ±500 ±10 ±10 20 20 500	
l _l	$V_{I} = 0$ to 5.5 V		3.6 V			±5	μA
	V _I = 0.58 V	1.65.1/	(2)				
	V _I = 1.07 V	1.05 V	(2)				
	V _I = 0.7 V	2.2.1/	45				
I _{I(hold)}	V _I = 1.7 V		2.3 V	-45			μΑ
	V _I = 0.8 V		2.1/	75			
	V _I = 2 V		- 3V	-75			
	$ \begin{array}{c c c c c c c c } \mbox{H} \begin{tabular}{ c c c c c } \mbox{H} \end{tabular} & 1.65 \ V \ 0 \ 3.6 \ V \ 0 \ 1_{OH} = -4 \ mA & 1.65 \ V $			±500			
I _{off}	$V_{I} \text{ or } V_{O} = 5.5 \text{ V}$		0			±10	μA
I _{OZ}	$V_{O} = 0$ to 5.5 V		3.6 V			±10	μA
1	$V_{I} = V_{CC}$ or GND	n	261/			20	μA
ICC	$3.6 \text{ V} \le \text{V}_{\text{I}} \le 5.5 \text{ V}^{(4)}$	5	3.0 V			20	
ΔI_{CC}	One input at $V_{CC} - 0.6 V$, Othe	r inputs at V _{CC} or GND	2.7 V to 3.6 V			500	μA
Ci	$V_{I} = V_{CC}$ or GND		3.3 V		5		pF
Co	$V_{O} = V_{CC}$ or GND		3.3 V		6.5		pF

(1)

All typical values are at V_{CC} = 3.3 V, T_A = 25°C. This information was not available at the time of publication. (2)

(3) This is the bus-hold maximum dynamic current required to switch the input from one state to another.

(4) This applies in the disabled state only.

Timing Requirements

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

		$ \begin{array}{c c} V_{CC} = 1.8 \ V & V_{CC} = 2.5 \ V \\ \pm \ 0.15 \ V & \pm \ 0.2 \ V & \\ \end{array} \right. V_{C} $		V _{CC} =	$V_{CC} = 2.7 V$ $V_{CC} = 3.1 \\ \pm 0.3 V$		3.3 V 3 V	UNIT		
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f _{clock}	Clock frequency		(1)		(1)		150		150	MHz
tw	Pulse duration, CLK high or low	(1)		(1)		3.3		3.3		ns
t _{su}	Setup time, data before CLK↑	(1)		(1)		1.9		1.9		ns
t _h	Hold time, data after CLK↑	(1)		(1)		1.1		1.1		ns

(1) This information was not available at the time of publication.

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Switching Characteristics

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM TO (INPUT) (OUTPUT)		V _{CC} = ± 0.1			V _{CC} = 2.7 V		V_{CC} = 3.3 V ± 0.3 V		UNIT	
	(INFOT)	(001201)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f _{max}			(1)		(1)		150		150		MHz
t _{pd}	CLK	Q	(1)	(1)	(1)	(1)		4.9	1.5	4.5	ns
t _{en}	OE	Q	(1)	(1)	(1)	(1)		5.3	1.5	4.6	ns
t _{dis}	ŌĒ	Q	(1)	(1)	(1)	(1)		6.1	1.5	5.5	ns
t _{sk(o)}										1	ns

(1) This information was not available at the time of publication.

Operating Characteristics

 $T_A = 25^{\circ}C$

PARAMETER			TEST CONDITIONS	V _{CC} = 1.8 V TYP	V _{CC} = 2.5 V TYP	V _{CC} = 3.3 V TYP	UNIT
C	Power dissipation capacitance	Outputs enabled	f = 10 MHz	(1)	(1)	58	pF
C _{pd}	per flip-flop	Outputs disabled		(1)	(1)	24	

(1) This information was not available at the time of publication.

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VI

0 V

٧ı

0 V

٧ı

0 V

VoL

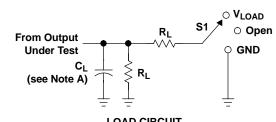
VOH

≈0 V

V_{LOAD}/2

VM

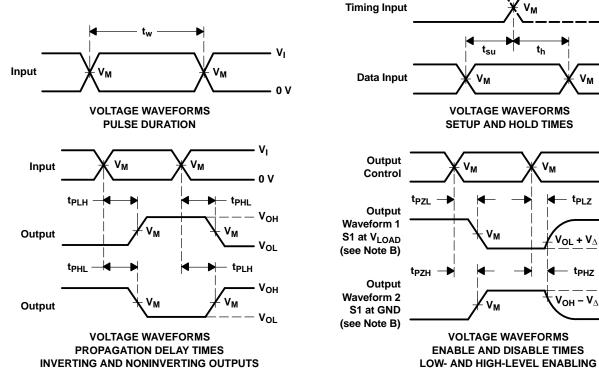
PARAMETER MEASUREMENT INFORMATION



S1
Open V _{LOAD} GND

-0/	 	

N N	INPUTS		N	V	•	-	
V _{CC}	VI	t _r /t _f	V _M	V _{LOAD}	CL	RL	V_{Δ}
$1.8~V\pm0.15~V$	V _{CC}	≤2 ns	V _{CC} /2	$2 \times V_{CC}$	30 pF	1 k Ω	0.15 V
2.5 V \pm 0.2 V	V _{CC}	≤2 ns	V _{CC} /2	$2 \times V_{CC}$	30 pF	500 Ω	0.15 V
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V
3.3 V \pm 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω .
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. t_{PLH} and t_{PHL} are the same as t_{pd} .
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms

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PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
74LVCH16374ADGGRG4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74LVCH16374ADGVRE4	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74LVCH16374ADLG4	ACTIVE	SSOP	DL	48	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74LVCH16374ADLRG4	ACTIVE	SSOP	DL	48	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVCH16374ADGGR	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVCH16374ADGVR	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVCH16374ADL	ACTIVE	SSOP	DL	48	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVCH16374ADLR	ACTIVE	SSOP	DL	48	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVCH16374AGQLR	ACTIVE	BGA MI CROSTA R JUNI OR	GQL	56	1000	TBD	SNPB	Level-1-240C-UNLIM
SN74LVCH16374AZQLR	ACTIVE	BGA MI CROSTA R JUNI OR	ZQL	56	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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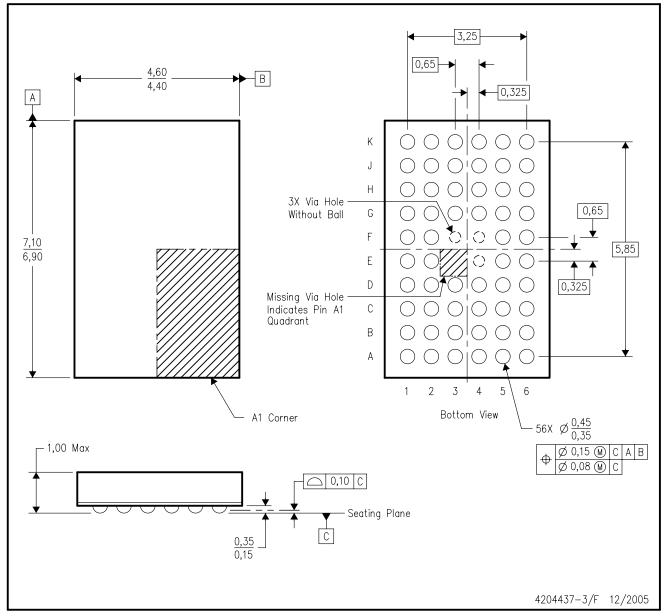
PACKAGE OPTION ADDENDUM



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ZQL (R-PBGA-N56)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-225 variation BA.
- D. This package is lead-free. Refer to the 56 GQL package (drawing 4200583) for tin-lead (SnPb).



MECHANICAL DATA

PLASTIC SMALL-OUTLINE

MPDS006C - FEBRUARY 1996 - REVISED AUGUST 2000

DGV (R-PDSO-G**)

24 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

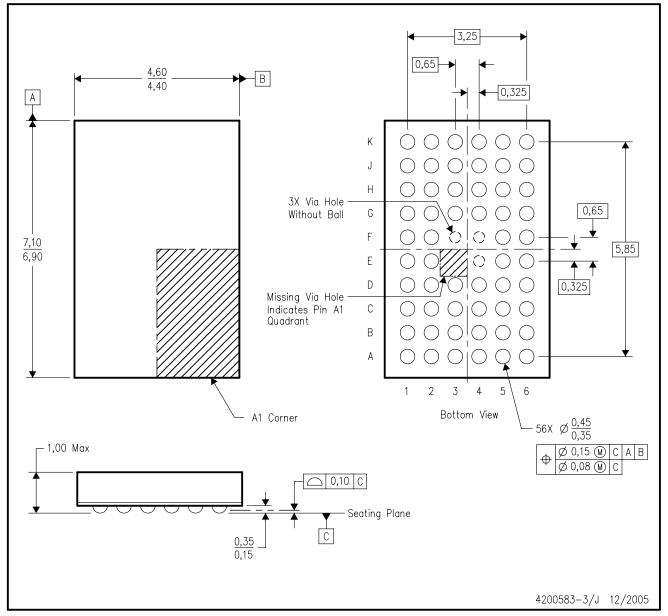
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
- D. Falls within JEDEC: 24/48 Pins MO-153

14/16/20/56 Pins – MO-194



GQL (R-PBGA-N56)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-225 variation BA.
- D. This package is tin-lead (SnPb). Refer to the 56 ZQL package (drawing 4204437) for lead-free.



MECHANICAL DATA

MSSO001C - JANUARY 1995 - REVISED DECEMBER 2001

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN

DL (R-PDSO-G**)



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MO-118



MECHANICAL DATA

MTSS003D - JANUARY 1995 - REVISED JANUARY 1998

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



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